Effect of Rare Earth (Sm) ion Substitution on Structural, Dielectric, and Transport Properties of PZT Ceramics

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Abstract: Solid solutions of Pb₁₋ₓSmₓ(Zr₁₋ₓTiₓO₂)₁₋ₓ/₄O₃ (PSZT) (x = 0.00, 0.04, 0.08 and 0.12) were synthesized by mixed oxide method at high temperature. The formation of single – phase compounds were confirmed by X- ray diffraction studies which were found to be in tetragonal phase at room temperature. The temperature dependence of dielectric response of the samples at selected frequencies has exhibit their phase transition well above the room temperature. The variation of ac conductivity with temperature reveals that their conduction process is of mixed type.

Keywords: PZT, Diffraction, Conductivity, Dielectric, Temperature

1. Introduction

There has been considerable interest in the solid solutions of lead zirconate–titinate, Pb(Zr₁₋ₓTiₓ)O₂ (PZT) with a perovskite ABO₃ type (A=mono or divalent, B=tri-hexavalent ion) structure due to its possible forefront applications in the areas of research as well as in industrial applications [1-6]. A considerable amount of works have been done on modified PZT ceramics prepared from high-temperature solid-state reaction technique. It is found that the properties of PZT are very much sensitive to its chemical substitutions, synthesis process, and some other factors. It is well observed that the La-modified PZT has tremendous applications in electronics and electro-optics [6-8]. The literature survey on pure and modified PZT materials reveals that no systematic studies have been reported on physical properties and device parameters of La-modified PZT (i.e., PSZT) with Zr/Ti ratio 40/60 [9-13]. In view of the above, we have studied the effect of samarium substitution on structural, dielectric, and ac conductivity properties of PZT (Zr/Ti: 40/60) ceramics, which is reported here.

2. Experimental Details

The polycrystalline samples of Sm – modified PZT Pb₁₋ₓSmₓ(Zr₀.₅Ti₀.₅)₁₋ₓ/₄O₃ (where x = 0.00, 0.04, 0.08, and 0.12) were prepared by a high- temperature solid-state reaction technique using high-purity (99.9%) oxides (i.e., PbO, ZrO₂, TiO₂, and Sm₂O₃) in a suitable stoichiometry with 3% more PbO (to compensate lead loss at high temperatures). The homogeneous mixed ingredients were calcined at an optimized temperature and time (1100°C, 10 hours) in an alumina crucible. The calcined powders, with small amount of polyvinyl alcohol (PVA) as binder, were converted into pellets at a pressure of 4 × 10⁶ N/m² using hydraulic press. These pellets were sintered in an alumina crucible at an optimized temperature and time (1200°C, 10 hours) aiming to get nearly 97% of theoretical density. The X-ray diffraction (XRD) data on the calcined powders were recorded using X-ray diffractometer (Rigaku Miniflex, Japan) with λ = 1.5405 Å in a wide range of Bragg’s angles 2θ (20° ≤ 2θ ≤ 80°) at a scanning rate of 3°/minute. The dielectric data of the materials were obtained on silver electrodeed samples using phase sensitive multimeter (PSM; Model 1735) in a wide range of frequency (10²–10⁸ Hz) and temperature (room temperature - 500°C) at a potential difference of 1V with the stabilized temperature at an interval of 2.5°C.

3. Results and Discussion

3.1 Structural Analysis

The nature of room temperature XRD patterns of Pb₁₋ₓSmₓ(Zr₀.₅Ti₀.₅)₁₋ₓ/₄O₃ (PSZT) with x = 0.00, 0.04, 0.08, and 0.12.

Figure 1: The comparison of XRD patterns of Pb₁₋ₓSmₓ(Zr₀.₅Ti₀.₅)₁₋ₓ/₄O₃ (for x = 0.00, 0.04, 0.08, and 0.12).

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gradually on increasing Sm content in PSZT. However, for
value of \( T_c \) is found to be highest for PZT which decreases of \( \varepsilon_{\text{max}} \) exhibits a sharp decrease for \( x = 0.04 \), then an highest for PZT. As Sm content in PSZT increases, the value

The variation of relative dielectric constant \( (\varepsilon_r) \) of PSZT (having Sm contents \( x = 0.00, 0.04, 0.08, \) and 0.12) with temperature at selected frequencies \( (10^4 - 10^6 \ \text{Hz}) \) is shown in Figure 2. It is found that \( \varepsilon_r \) decreases on increasing frequency which indicates a normal behavior of the ferroelectric and/or dielectric materials. The higher values of \( \varepsilon_r \) at lower frequency are due to the simultaneous presence of all types of polarizations (space charge, dipolar, ionic, electronic, etc.) which is found to decrease with the increase in frequency. At high frequencies \( (>10^{12} \ \text{Hz}) \) electronic polarization only exists in the materials. When temperature of PSZT samples is increased, \( \varepsilon_r \) first increases slowly and then rapidly up to a maximum value \( (\varepsilon_{\text{max}}) \). Temperature of the material corresponding to \( \varepsilon_{\text{max}} \) is called Curie or critical temperature \( (T_c) \). As at this \( T_c \), phase transition takes place between ferroelectric-pyroelectric phases so it is also called transition temperature. At the higher temperature \( (\geq T_c) \), the space charge polarization originates due to mobility of ions and imperfections in materials and thus contributes to a sharp increase in \( \varepsilon_r \) [21, 22]. The value of \( \varepsilon_{\text{max}} \) is found to be highest for PZT. As Sm content in PSZT increases, the value of \( \varepsilon_{\text{max}} \) exhibits a sharp decrease for \( x = 0.04 \), then an increase for \( x = 0.08 \), and again decrease for \( x = 0.12 \). The value of \( T_c \) is found to be highest for PZT which decreases gradually on increasing Sm content in PSZT. However, for each PSZT samples \( T_c \) is found to be unaffected with the change in frequency supporting the nonrelaxor behavior of Sm-modified PZT. The values of \( \varepsilon_{\text{max}} \) and \( T_c \) of PSZT are compared in Table 1.

The frequency-temperature dependence of tangent loss \( (\tan \delta) \) of PSZT is shown in Figure 2. With the increase in temperature, \( \tan \delta \) is found to be very low and almost remains constant up to \( T_c \) beyond which it indicates a significant increase. The nature of variation of \( \tan \delta \) at higher frequency and temperature can be explained by space-charge polarization. This \( \tan \delta \) decreases with the increase in frequency as expected [23, 24].

### 3.3 Ac Conductivity

The ac conductivity \( (\sigma_{\text{ac}}) \) of PSZT for \( x = 0.00, 0.04, 0.08, \) and 0.12 at frequency 10 kHz was calculated using dielectric relation

\[
\sigma_{\text{ac}} = \frac{\varepsilon_0 \omega \varepsilon_r \tan \delta}{2}, \quad (1)
\]

where \( \omega \) is the angular frequency and \( \varepsilon_0 \) the permittivity of free space. Figure 3 shows an increasing trend of ac conductivity around \( T_c \). A sharp maximum in \( \sigma_{\text{ac}} \) at \( T_c \) (observed by dielectric analysis) indicates a marked dispersion which may be due to the increase in polarizability. Above \( T_c \), the conductivity data appears to fall on a straight line exhibiting a typical behavior of the dc component of the conductivity [23]. The linear variation of \( \sigma_{\text{ac}} \) over a wide range of temperature supports the existence of thermally activated transport properties in the materials following the Arrhenius equation:

\[
\sigma_{\text{ac}} = \sigma_0 \exp\left(- \frac{E_a}{k_B T}\right), \quad (2)
\]

where \( \sigma_0 \) is the pre-exponential factor, \( KB \) the Boltzmann constant and \( E_a \) the activation energy. The value of activation energy \( (E_a) \) of PSZT was found to be 0.93, 0.57, 1.45, and 0.79 for \( x = 0.00, 0.04, 0.08, \) and 0.12, respectively, in the high-temperature pyroelectric phase which suggests its dependence on ionization level of oxygen vacancy [25].
4. Conclusions

Preliminary structural analysis using room temperature X-ray diffraction data obtained from the calcined powders of polycrystalline samples of Sm-modified PZT (i.e., \(\text{PB}_{1-x}\text{Sm}_x (\text{Zr}_{0.4}\text{Ti}_{0.6})_{1-x/4}\text{O}_3\)) has confirmed their tetragonal phase with the presence of a small amount of pyrochlore phase during higher concentration of Sm (3% for \(x = 0.08\) and 7% for 0.12). Detailed study of dielectric properties of PSZT as a function of temperature at selected frequencies has exhibited that maximum or peak dielectric constant, tangent loss, and transition temperature are strongly dependent on Sm content in PSZT. The electrical conductivity (ac) of PSZT may not only due to singly ionized in low temperature (ferroelectric phase) region but also due to doubly ionized in the high-temperature region.

References


Figure 2: Temperature-frequency dependence of relative dielectric constant (\(\varepsilon_r\)) and tangent loss (tan \(\delta\))

\(\text{PB}_{1-x}\text{Sm}_x (\text{Zr}_{0.4}\text{Ti}_{0.6})_{1-x/4}\text{O}_3\) for \(x = 0.00, 0.04, 0.08,\) and 0.12.

Table 1: Comparison of the lattice parameters, \(\varepsilon_{\text{max}}\) and \(T_c\) of \(\text{PB}_{1-x}\text{Sm}_x (\text{Zr}_{0.4}\text{Ti}_{0.6})_{1-x/4}\text{O}_3\) for \(x = 0.00, 0.04, 0.08\) and 0.12

<table>
<thead>
<tr>
<th>Parameters</th>
<th>x = 0.00</th>
<th>x = 0.04</th>
<th>x = 0.08</th>
<th>x = 0.12</th>
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<tbody>
<tr>
<td>(a)</td>
<td>4.0042(21)</td>
<td>3.9966(50)</td>
<td>3.9725(50)</td>
<td>3.9785(50)</td>
</tr>
<tr>
<td>(c)</td>
<td>4.1348(21)</td>
<td>4.1146(50)</td>
<td>4.0844(50)</td>
<td>4.1081(50)</td>
</tr>
<tr>
<td>(c/a)</td>
<td>1.0326(21)</td>
<td>1.02952(50)</td>
<td>1.02816(50)</td>
<td>1.0325(50)</td>
</tr>
<tr>
<td>(\varepsilon_{\text{max}})</td>
<td>10850</td>
<td>3421</td>
<td>7186</td>
<td>4164</td>
</tr>
<tr>
<td>(T (\degree\text{C}))</td>
<td>404 ± 0.25</td>
<td>383 ± 0.25</td>
<td>371 ± 0.25</td>
<td>364 ± 0.25</td>
</tr>
</tbody>
</table>

Figure 3: Temperature-Frequency dependence of ac conductivity \(\text{PB}_{1-x}\text{Sm}_x (\text{Zr}_{0.4}\text{Ti}_{0.6})_{1-x/4}\text{O}_3\) for \(x = 0.00, 0.04, 0.08\) and 0.12.


